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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE 08 DEC 2005

In re the Application of

Shimpei MIURA

Application No.: New U.S. National Stage of

PCT/IB04/002019

Filed: December 8, 2005 Docket No.: 125628

For: FUEL CELL SYSTEM AND GAS LEAK DETECTION METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of the non-English language reference is discussed in the present specification.
- 3. An English language Abstract of the non-English language reference is attached hereto.

Respectfully submitted,

James A. Oliff Registration No. 27,075

Eric D. Morehouse Registration No. 38,565

JAO:EDM/crh

Date: December 8, 2005

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE
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Form PTO-1449 US Dept. of Commerce (REV. 8-83) PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT			ATTY I 125628	DOCKET NO.	New	APPLICATION NO. New U.S. National Stage of PCT/IB04/002019 931		
(Use several sheets if necessary)				APPLICANT Shimpei MIURA				
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U.S. PATENT DOCUMENTS								
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FOREIGN PATENT DOCUMENTS								
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)								
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EXAMINER /Stephen Kalafu					DATE CONSIDERED 02/24/2008			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

Date: December 8, 2005